

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination 09/911,287 VAN BEMMEL ET AL.	
		Examiner	Art Unit Thomas H. Stevens 2123	Page 1 of 2

**U.S. PATENT DOCUMENTS**

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	W	Stsine et al., "Analysis and Decomposition of Spatial Variation in Integrated Circuit Process and Devices" IEEE vol. 10, No. 1, pg. 24-41
	X	Liebold et al. "Testing for Correlation in the Presence of Spatial Autocorrelation in Insect Count Data" 1998 pg.1-8

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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